

Form PTO-1449 (REV. 8-83)		US Dept. of Commerce PATENT & TRADEMARK OFFICE	ATTY DOCKET NO. 118817		APPLICATION NO. New U.S. Patent Application	
INFORMATION DISCLOSURE STATEMENT (Use several sheets if necessary)		APPLICANT Yuuichi KAWAGUCHI				
		FILING DATE February 25, 2004		1756		
		U.S. PATENT DOCUMENTS				
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS
FOREIGN PATENT DOCUMENTS						
		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUB CLASS
ALV	1	JP A 08-045120 abst & trans only	02/16/1996	Japan		
ALV	2	JP B2 2663912	06/20/1997	Japan	—	—
OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, etc.)						
ALV		<i>Abstract + Translation of JP 08-045120</i>				
EXAMINER	<i>Ana Verdun</i>			DATE CONSIDERED <i>10/12/06</i>		
Examiner: Initial if citation considered, whether or not citation is in conformance with M.P.E.P. 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.						



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		DOCUMENT NUMBER	DATE	COUNTRY		CLASS	SUB CLASS
ALV	1	JP-A-2001-076344	03/25/2001	Japan		—	—
OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, etc.)							
EXAMINER <i>Anne Verderca</i>					DATE CONSIDERED <i>10/12/06</i>		
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